Search Notes



<b>Application</b>	n/Contro	l No.
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10/796,039 Examiner

Chen-Wen Jiang

Applicant(s)/Patent under Reexamination

MORIYAMA ET AL.

Art Unit

3744

SEARCHED					
Class	Subclass	Date	Examiner		
62	93R 101C				
	34.5				
123	41.1 41.08				
	41.44 41.3				
	41.4				
	41.41				
	41.05	4/6/2006	Cl		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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1				

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST Searched Inventor Searched	4/6/2006	СJ		